

<b>Notice of References Cited</b>	Application/Control No. 10/534,153		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Phylesha L. Dabney		Art Unit 2614	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,731,964	03-1998	Kitakubo et al.	361/816
*	B	US-7,136,681	11-2006	Sadler et al.	455/575.1
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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